

IEC TR 61000-4-1

Edition 1.0 2016-04

TECHNICAL REPORT

BASIC EMC PUBLICATION

Electromagnetic compatibility (EMC) – Part 4-1: Testing and measurement techniques – Overview of the IEC 61000-4 series

INTERNATIONAL ELECTROTECHNICAL COMMISSION

ICS 33.100.01; 33.100.20 ISBN 978-2-8322-3362-7

Warning! Make sure that you obtained this publication from an authorized distributor.

- 2 - IEC TR 61000-4-1:2016 © IEC 2016

CONTENTS

FΟ	REWORD	3
IN٦	TRODUCTION	5
1	Scope and object	6
2	Normative references	6
3	Terms and definitions	9
4	General	10
5	Structure of the IEC 61000-4 series	11
6	Applicability of tests	11
7	Test report	18
Bib	oliography	19
Tal	ble 1 – Applicability of immunity tests based on location (environment)	15
Table 2 – Applicability of immunity tests based on EUT ports		

- 3 -

INTERNATIONAL ELECTROTECHNICAL COMMISSION

ELECTROMAGNETIC COMPATIBILITY (EMC) -

Part 4-1: Testing and measurement techniques – Overview of the IEC 61000-4 series

FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as "IEC Publication(s)"). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
- 2) The formal decisions or agreements of IEC on technical matters express, as nearly as possible, an international consensus of opinion on the relevant subjects since each technical committee has representation from all interested IEC National Committees.
- 3) IEC Publications have the form of recommendations for international use and are accepted by IEC National Committees in that sense. While all reasonable efforts are made to ensure that the technical content of IEC Publications is accurate, IEC cannot be held responsible for the way in which they are used or for any misinterpretation by any end user.
- 4) In order to promote international uniformity, IEC National Committees undertake to apply IEC Publications transparently to the maximum extent possible in their national and regional publications. Any divergence between any IEC Publication and the corresponding national or regional publication shall be clearly indicated in the latter.
- 5) IEC itself does not provide any attestation of conformity. Independent certification bodies provide conformity assessment services and, in some areas, access to IEC marks of conformity. IEC is not responsible for any services carried out by independent certification bodies.
- 6) All users should ensure that they have the latest edition of this publication.
- 7) No liability shall attach to IEC or its directors, employees, servants or agents including individual experts and members of its technical committees and IEC National Committees for any personal injury, property damage or other damage of any nature whatsoever, whether direct or indirect, or for costs (including legal fees) and expenses arising out of the publication, use of, or reliance upon, this IEC Publication or any other IEC Publications.
- 8) Attention is drawn to the Normative references cited in this publication. Use of the referenced publications is indispensable for the correct application of this publication.
- 9) Attention is drawn to the possibility that some of the elements of this IEC Publication may be the subject of patent rights. IEC shall not be held responsible for identifying any or all such patent rights.

The main task of IEC technical committees is to prepare International Standards. However, a technical committee may propose the publication of a technical report when it has collected data of a different kind from that which is normally published as an International Standard, for example "state of the art".

IEC TR 61000-4-1, which is a technical report, has been prepared by IEC technical committee 77: Electromagnetic compatibility.

This Technical Report forms Part 4-1 of IEC 61000. It has the status of a basic EMC publication in accordance with IEC Guide 107.

This first edition as a Technical Report cancels and replaces the third edition of the International Standard published in 2006. This edition constitutes a technical revision.

- 4 - IEC TR 61000-4-1:2016 © IEC 2016

This edition includes the following significant technical changes with respect to the previous edition:

- a) updates the text to include reference to the latest publications of the IEC 61000-4 series;
- b) gives more detailed assignment between applicable immunity tests and the electromagnetic environment in which equipment is intended to be used.

The text of this standard is based on the following documents:

Enquiry draft	Report on voting
77/498/DTR	77/508/RVC

Full information on the voting for the approval of this technical report can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 61000 series, published under the general title *Electromagnetic* compatibility (EMC), can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC website under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- · reconfirmed,
- withdrawn,
- · replaced by a revised edition, or
- amended.

A bilingual version of this publication may be issued at a later date.

- 5 -

INTRODUCTION

IEC 61000 is published in several parts according to the following structure:

Part 1: General

General consideration (introduction, fundamental principles)
Definitions, terminology

Part 2: Environment

Description of the environment Classification of the environment Compatibility levels

Part 3: Limits

Emission limits

Immunity test levels (in so far as they do not fall under the responsibility of the product committees)

Part 4: Testing and measurement techniques

Measurement techniques
Testing techniques

Part 5: Installation and mitigation guidelines

Installation guidelines
Mitigation methods and devices

Part 6: Generic standards

Part 9: Miscellaneous

Each part is further subdivided into several parts, published either as International Standards, technical specifications or technical reports, some of which have already been published as sections. Others will be published with the part number followed by a dash and completed by a second number identifying the subdivision (example: 61000-6-1).

ELECTROMAGNETIC COMPATIBILITY (EMC) -

Part 4-1: Testing and measurement techniques – Overview of the IEC 61000-4 series

1 Scope and object

This part of IEC 61000 gives information and guidance on the EMC basic standards and other basic EMC documents published in the IEC 61000-4 series. Those basic standards describe mainly immunity tests to be considered and applied for electric and electronic equipment, including systems.

The object of this part of IEC 61000 is to give assistance to the technical committees of IEC or other bodies, users and manufacturers in

- considering the immunity test methods applicable to their products;
- determining the immunity test methods relevant for the electromagnetic environment in which their products are intended to be used;
- specifying the ports of their products being subjected to the relevant immunity test methods.

2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60050-161, International Electrotechnical Vocabulary (IEV) – Part 161: Electromagnetic compatibility (available at http://www.electropedia.org)

IEC TR 61000-1-1, Electromagnetic compatibility (EMC) – Part 1: General – Section 1: Application and interpretation of fundamental definitions and terms

IEC TR 61000-2-5, Electromagnetic compatibility (EMC) – Part 2-5: Environment – Description and classification of electromagnetic environments

IEC 61000-3-2, Electromagnetic compatibility (EMC) – Part 3-2: Limits – Limits for harmonic current emissions (equipment input current ≤16 A per phase)

IEC 61000-3-3, Electromagnetic compatibility (EMC) – Part 3-3: Limits – Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems, for equipment with rated current \leq 16 A per phase and not subject to conditional connection

IEC TR 61000-3-4, Electromagnetic compatibility (EMC) – Part 3-4: Limits – Limitation of emission of harmonic currents in low-voltage power supply systems for equipment with rated current greater than 16 A

IEC TS 61000-3-5, Electromagnetic compatibility (EMC) – Part 3-5: Limits – Limitation of voltage fluctuations and flicker in low-voltage power supply systems for equipment with rated current greater than 75 A

-7-

- IEC TR 61000-3-6, Electromagnetic compatibility (EMC) Part 3-6: Limits —Assessment of emission limits for the connection of distorting installations to MV, HV and EHV power systems
- IEC 61000-3-11, Electromagnetic compatibility (EMC) Part 3-11: Limits Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems Equipment with rated current \leq 75 A and subject to conditional connection
- IEC 61000-3-12, Electromagnetic compatibility (EMC) Part 3-12: Limits Limits for harmonic currents produced by equipment connected to public low-voltage systems with input current >16 A and \leq 75 A per phase
- IEC 61000-4-2, Electromagnetic compatibility (EMC) Part 4-2: Testing and measurement techniques Electrostatic discharge immunity test
- IEC 61000-4-3, Electromagnetic compatibility (EMC) Part 4-3: Testing and measurement techniques Radiated, radio-frequency, electromagnetic field immunity test
- IEC 61000-4-4, Electromagnetic compatibility (EMC) Part 4-4: Testing and measurement techniques Electrical fast transient/burst immunity test
- IEC 61000-4-5, Electromagnetic compatibility (EMC) Part 4-5: Testing and measurement techniques Surge immunity test
- IEC 61000-4-6, Electromagnetic compatibility (EMC) Part 4-6: Testing and measurement techniques Immunity to conducted disturbances, induced by radio-frequency fields
- IEC 61000-4-7, Electromagnetic compatibility (EMC) Part 4-7: Testing and measurement techniques General guide on harmonics and interharmonics measurements and instrumentation, for power supply systems and equipment connected thereto
- IEC 61000-4-8, Electromagnetic compatibility (EMC) Part 4-8: Testing and measurement techniques Power frequency magnetic field immunity test
- IEC 61000-4-9, Electromagnetic compatibility (EMC) Part 4-9: Testing and measurement techniques Pulse magnetic field immunity test
- IEC 61000-4-10, Electromagnetic compatibility (EMC) Part 4-10: Testing and measurement techniques Damped oscillatory magnetic field immunity test
- IEC 61000-4-11, Electromagnetic compatibility (EMC) Part 4-11: Testing and measurement techniques Voltage dips, short interruptions and voltage variations immunity tests
- IEC 61000-4-12, Electromagnetic compatibility (EMC) Part 4-12: Testing and measurement techniques Ring wave immunity test
- IEC 61000-4-13, Electromagnetic compatibility (EMC) Part 4-13: Testing and measurement techniques Harmonics and interharmonics including mains signalling at a.c. power port, low frequency immunity tests
- IEC 61000-4-14, Electromagnetic compatibility (EMC) Part 4-14: Testing and measurement techniques Voltage fluctuation immunity test for equipment with input current not exceeding 16 A per phase

- 8 - IEC TR 61000-4-1:2016 © IEC 2016

- IEC 61000-4-15, Electromagnetic compatibility (EMC) Part 4-15: Testing and measurement techniques Flickermeter Functional and design specifications 1
- IEC 61000-4-16, Electromagnetic compatibility (EMC) Part 4-16: Testing and measurement techniques Test for immunity to conducted, common mode disturbances in the frequency range 0 Hz to 150 kHz
- IEC 61000-4-17, Electromagnetic compatibility (EMC) Part 4-17: Testing and measurement techniques Ripple on d.c. input power port immunity test
- IEC 61000-4-18, Electromagnetic Compatibility (EMC) Part 4-18: Testing and measurement techniques Damped oscillatory wave immunity test
- IEC 61000-4-19, Electromagnetic Compatibility (EMC) Part 4-19: Testing and measurement techniques Test for immunity to conducted, differential mode disturbances and signalling in the frequency range 2 kHz to 150 kHz at a.c. power ports
- IEC 61000-4-20, Electromagnetic compatibility (EMC) Part 4-20: Testing and measurement techniques Emission and immunity testing in transverse electromagnetic (TEM) waveguides
- IEC 61000-4-21, Electromagnetic compatibility (EMC) Part 4-21: Testing and measurement techniques Reverberation chamber test methods
- IEC 61000-4-22, Electromagnetic compatibility (EMC) Part 4-22: Testing and measurement techniques Radiated emissions and immunity measurements in fully anechoic rooms (FARs)
- IEC 61000-4-23, Electromagnetic compatibility (EMC) Part 4-23: Testing and measurement techniques Test methods for protective devices for HEMP and other radiated disturbances
- IEC 61000-4-24, Electromagnetic compatibility (EMC) Part 4-24: Testing and measurement techniques Test methods for protective devices for HEMP conducted disturbance
- IEC 61000-4-25, Electromagnetic compatibility (EMC) Part 4-25: Testing and measurement techniques HEMP immunity test methods for equipment and systems
- IEC 61000-4-27, Electromagnetic compatibility (EMC) Part 4-27: Testing and measurement techniques Unbalance, immunity test for equipment with input current not exceeding 16 A per phase
- IEC 61000-4-28, Electromagnetic compatibility (EMC) Part 4-28: Testing and measurement techniques Variation of power frequency, immunity test for equipment with input current not exceeding 16 A per phase
- IEC 61000-4-29, Electromagnetic compatibility (EMC) Part 4-29: Testing and measurement techniques Voltage dips, short interruptions and voltage variations on d.c. input power port immunity tests
- IEC 61000-4-30, Electromagnetic compatibility (EMC) Part 4-30: Testing and measurement techniques –Power quality measurement methods
- IEC TR 61000-4-32, Electromagnetic compatibility (EMC) Part 4-32: Testing and measurement techniques High-altitude electromagnetic pulse (HEMP) simulator compendium

Revision of IEC 60868.

_ 9 _

IEC 61000-4-33, Electromagnetic compatibility (EMC) – Part 4-33: Testing and measurement techniques – Measurement methods for high-power transient parameters

IEC 61000-4-34, Electromagnetic compatibility (EMC) – Part 4-34: Testing and measurement techniques – Voltage dips, short interruptions and voltage variations immunity tests for equipment with input current more than 16 A per phase

IEC TR 61000-4-35, Electromagnetic compatibility (EMC) – Part 4-35: Testing and measurement techniques – HPEM simulator compendium

IEC 61000-4-36, Electromagnetic compatibility (EMC) – Part 4-36: Testing and measurement techniques – IEMI immunity test methods for equipment and systems

IEC TR 61000-4-38, Electromagnetic compatibility (EMC) – Part 4-38: Testing and measurement techniques – Test, verification and calibration protocol for voltage fluctuation and flicker compliance test systems